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 Systems, Man and Cybernetics, 1992., IEEE International Conference on , 18-
 Oct. 1992

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 Artificial Intelligence for Applications, 1992., Proceedings of the Eighth Confer-
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18 LED: an educational tool for electric circuit design
Di Cataldo, G.; Nunnari, G.;

 Electrotechnical Conference, 1989. Proceedings. 'Integrating Research, Indus-
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 Mediterranean , 11-13 April 1989

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**19 Development of a knowledge-based (expert) system (PECT) for po
electronic circuit design**
Cumbi, M.J.N.; Shepherd, D.W.; Hulley, L.N.;

 Power Electronics and Applications, 1993., Fifth European Conference on , 13
 Sep 1993

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Artificial Intelligence in Planning for Production Control, IEE Colloquium on , 2
1988

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